# Introduction to Texas Instruments Space Enhanced Plastic Products

## TEXAS INSTRUMENTS

#### Introduction

In addition to the large QMLV selection, TI has begun to offer a leading-edge portfolio of plastic devices for Low Earth Orbit (LEO) missions with short mission life, and requirements for small size. This encompasses the emerging term, "New Space", loosely defined as covering some of the trends in the space community, including the emerging private spaceflight industry and programs that have reduced reliability, lifetime and radiation requirements. There are unique challenges with the space environment such as radiation requirements, thermal cycling and outgassing. TI has addressed this with a new line of rigorously developed products, Space-Enhanced Plastics (SEP).

Space-EP devices offer the following advantages over standard catalog products:

- Controlled baseline with one wafer fab, one assembly site, one material set.
- Optimized material set with die attach, mold compound, leadframe and bond wire all selected to maximize reliability.
- No high tin (>97% Sn) construction including terminations (SnAgCu solderballs and Matte-Sn plating) or internal package components (die bumps or substrate plating).
- No copper bond wire. Product is either flipchip mounted (no bond wire) or uses gold bond wire.
- Additional assembly processing including 100% temperature cycle or 100% single-pass reflow simulation in lieu of temperature cycle.
- Characterization over target temperature range (–55°C to +125°C).

- Parametric testing is standard at both room and high temperatures with guardbands to assure datasheet limits at cold temperature.
- Assembly lot acceptance including x-ray sampling and CSAM sampling.
- Wafer lot acceptance using MIL-PRF-38535 QML Class V as baseline.
- Radiation Lot Acceptance Testing (Group E) to 20krad TID for each wafer lot per MIL-STD-883.
- One time characterization testing to 30-krad TID per MIL-STD-883.
- SEL characterization to 43 MeV-cm2/mg.
- Outgassing qualification for each product per ASTM E-595.
- Qualification to SMC-SO-11.

Space applications require known radiation performance. Not only are TI Space-EP products characterized for total dose and single event radiation performance, but in many cases different wafer fabrication processes or alternate

die designs are used to achieve specified levels of radiation tolerance. This is further ensured with a radiation lot acceptance test (RLAT or Group E) performed on each Space-EP wafer lot. An OEM may be tempted to characterize one lot of product and then assume that subsequent material will perform the same. This is not always true. Depending on the process technology, some devices exhibit a significant wafer lot to wafer lot variation and, in some cases, a wafer to wafer variation. Since traceability of Commerical Off The Shelf (COTS) material is only to the wafer lot level, it creates a substantial risk to the OEM.

Texas Instruments Space-EP provides a very cost effective means of mitigating the risks associated with using commercial off-the shelf plastic encapsulated microcircuits. TI's approach, combining the best of the Enhanced Product methodology and Class V-like wafer processing, ensures a product that meets published specifications in critical space and launch vehicle applications, while providing small size and reduced system cost.



TI is currently offering five SEP devices, and is planning to offer many more in a variety of functions.

- TLV1704-SEP 2.2-V to 36-V, radiation hardened microPower quad comparator in space-enhanced plastic
- <u>IN240-SEP</u> —80-V, low-/high-side, zero-drift, current sense amp with
- enhanced PWM rejection in space-enhanced plastic
- TL7700-SEP Voltage supervisor in space-enhanced plastic
- TPS73801-SEP—Radiation-hardened 1-A low-noise fast-transient-response LDO in space-enhanced plastic
- SN55HVD233-SEP Radiation-hardened 3.3-V CAN transceiver in space-enhanced plastic package with standby mode

For more information on the device roadmap and offerings, please contact your TI representative, or reach out to TI through the E2E<sup>TM</sup> community or **ti.com/sep**.

## **Space-Enhanced Plastic Products**

Generic Part Number	Description	Orderable Material	Subfamily	Pin	PKG	PKG Group	ECCN <sup>1</sup>
INA240-SEP	80-V, low-/high-side, zero-drift, current sense amp w/ enhanced PWM rejection in space-enhanced plastic package	INA240PMPWPSEP	Current sense amplifiers	8	PW	TSS0P	EAR99
		INA240PMPWTPSEP		8	PW	TSS0P	EAR99
		V62/18615-01XE		8	PW	TSS0P	EAR99
		V62/18615-01XE-T		8	PW	TSS0P	EAR99
SN55HVD233-SEP	3.3-V CAN transceiver in space-enhanced plastic package with standby mode	SN55HVD233MDPSEP	CAN	8	D	SOIC	EAR99
		SN55HVD233MDTPSEP		8	D	SOIC	EAR99
		V62/18617-01XE		8	D	SOIC	EAR99
		V62/18617-01XE-T		8	D	SOIC	EAR99
SN65C1168E-SEP	Dual differential drivers and receivers with $\pm$ 8-kV IEC ESD protection in space-enhanced plastic	SN65C1168EMPWSEP	RS-485/RS-422	16	PW	TSS0P	EAR99
		SN65C1168EMPWTSEP		16	PW	TSS0P	EAR99
TL7700-SEP	Supply-voltage supervisor in space-enhanced plastic package	TL7700CMPWPSEP	Supervisor IC	8	PW	TSS0P	EAR99
		TL7700CMPWTPSEP		8	PW	TSS0P	EAR99
		V62/19602-01XE		8	PW	TSS0P	EAR99
		V62/19602-01XE-T		8	PW	TSS0P	EAR99
TLV1704-SEP	2.2-V to 36-V, microPower quad comparator in space-enhanced plastic package	TLV1704AMPWPSEP	Comparator	14	PW	TSS0P	EAR99
		TLV1704AMPWTPSEP		14	PW	TSS0P	EAR99
		V62/18613-01XE		14	PW	TSS0P	EAR99
		V62/18613-01XE		14	PW	TSS0P	EAR99
TPS73801-SEP	1-A low-noise fast-transient-response LDO in space-enhanced plastic package	TPS73801MDCQPSEP	Linear regulators (LDO)	6	DCQ	S0T-223	EAR99
		TPS73801MDCQTPSEP		6	DCQ	S0T-223	EAR99
		V62/18616-01XE		6	DCQ	S0T-223	EAR99
		V62/18616-01XE-T		6	DCQ	S0T-223	EAR99

<sup>1)</sup> ECCN information for products that are EAR99 are shown. For up-to-date ECCN information on any product, please request from: gtc\_eccn-hts-naftateam@list.ti.com.

## TI Worldwide Technical Support

## **TI Support**

Thank you for your business. Find the answer to your support need or get in touch with our support center at <a href="https://www.ti.com/support">www.ti.com/support</a>

China: <a href="http://www.ti.com.cn/guidedsupport/cn/docs/supporthome.tsp">http://www.ti.com.cn/guidedsupport/cn/docs/supporthome.tsp</a>
Japan: <a href="http://www.tij.co.jp/guidedsupport/jp/docs/supporthome.tsp">http://www.tij.co.jp/guidedsupport/jp/docs/supporthome.tsp</a>

## **Technical support forums**

Search through millions of technical questions and answers at TI's E2E™ Community (engineer-to-engineer) at e2e.ti.com

China: <a href="http://www.deyisupport.com/">http://www.deyisupport.com/</a> Japan: <a href="http://e2e.ti.com/group/ip/">http://e2e.ti.com/group/ip/</a>

### **TI Training**

From technology fundamentals to advanced implementation, we offer on-demand and live training to help bring your next-generation designs to life. Get started now at **training.ti.com** 

China: http://www.ti.com.cn/general/cn/docs/gencontent.tsp?contentId=71968

Japan: <a href="https://training.ti.com/jp">https://training.ti.com/jp</a>

B011617

Important Notice: The products and services of Texas Instruments Incorporated and its subsidiaries described herein are sold subject to TI's standard terms and conditions of sale. Customers are advised to obtain the most current and complete information about TI products and services before placing orders. TI assumes no liability for applications assistance, customer's applications or product designs, software performance, or infringement of patents. The publication of information regarding any other company's products or services does not constitute TI's approval, warranty or endorsement thereof.

The platform bar, C6000, E2E, LinCMOS and MSP430 are trademarks and WEBENCH is a registered trademark of Texas Instruments. All other trademarks are the property of their respective owners.



#### IMPORTANT NOTICE AND DISCLAIMER

TI PROVIDES TECHNICAL AND RELIABILITY DATA (INCLUDING DATASHEETS), DESIGN RESOURCES (INCLUDING REFERENCE DESIGNS), APPLICATION OR OTHER DESIGN ADVICE, WEB TOOLS, SAFETY INFORMATION, AND OTHER RESOURCES "AS IS" AND WITH ALL FAULTS, AND DISCLAIMS ALL WARRANTIES, EXPRESS AND IMPLIED, INCLUDING WITHOUT LIMITATION ANY IMPLIED WARRANTIES OF MERCHANTABILITY, FITNESS FOR A PARTICULAR PURPOSE OR NON-INFRINGEMENT OF THIRD PARTY INTELLECTUAL PROPERTY RIGHTS.

These resources are intended for skilled developers designing with TI products. You are solely responsible for (1) selecting the appropriate TI products for your application, (2) designing, validating and testing your application, and (3) ensuring your application meets applicable standards, and any other safety, security, or other requirements. These resources are subject to change without notice. TI grants you permission to use these resources only for development of an application that uses the TI products described in the resource. Other reproduction and display of these resources is prohibited. No license is granted to any other TI intellectual property right or to any third party intellectual property right. TI disclaims responsibility for, and you will fully indemnify TI and its representatives against, any claims, damages, costs, losses, and liabilities arising out of your use of these resources.

TI's products are provided subject to TI's Terms of Sale (<a href="www.ti.com/legal/termsofsale.html">www.ti.com/legal/termsofsale.html</a>) or other applicable terms available either on ti.com or provided in conjunction with such TI products. TI's provision of these resources does not expand or otherwise alter TI's applicable warranties or warranty disclaimers for TI products.

Mailing Address: Texas Instruments, Post Office Box 655303, Dallas, Texas 75265 Copyright © 2019, Texas Instruments Incorporated